



Sheet 1 of 1

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 108455	APPLICATION NO. 09/769,832	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		APPLICANT(S) Yasuhiro OMURA et al.				
		FILING DATE January 26, 2001		GROUP 2851		
		U.S. PATENT DOCUMENTS				
Examiner Initials	Cite No.	Document Number	Date	Name		
FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
RF	1	JP-A-6-250074	9-9-1994	JAPAN		x
RF	2	JP-A-6-265789	9-22-1994	JAPAN		x
RF	3	JP-A-6-349699	12-22-1994	JAPAN		x
RF	4	JP-A-7-168116	7-4-1995	JAPAN		x
RF	5	JP-A-9-312254	12-2-1997	JAPAN		x
RF	6	JP-A-11-84199	3-26-1999	JAPAN		x
RF	7	JP-A-11-194479	7-21-1999	JAPAN		x
RF	8	JP-A-11-231192	8-27-1999	JAPAN		x
RF	9	JP-A-2000-12453	1-14-2000	JAPAN		x
RF	10	JP-A-2000-28898	1-28-2000	JAPAN		x
RF	11	JP-A-2000-29202	1-28-2000	JAPAN		x
RF	12	JP-A-2000-47114	2-18-2000	JAPAN		x
OTHER DOCUMENTS						
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)				
EXAMINER /Rodney Fuller/						DATE CONSIDERED 10/26/2006
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						



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U.S. PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number	Date	Name	
RF	1	2002/0145711 A1	10-10-2002	Magome et al.	
RF	2	2002/0196533 A1	12-26-2002	Shafer et al.	
RF	3	2003/0020888 A1	01-30-2003	Tanaka et al.	
RF	4	2004/0104359 A1	06-03-2004	Komatsuda et al.	
RF	5	5,689,377	11-18-1997	Takahashi	
RF	6	5,694,241	12-2-1997	Ishiyama et al.	
RF	7	5,805,334	09-08-1998	Takahashi	
FOREIGN PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract With English Translation
RF	8	JP-A-7-168116	07-04-1995	Japan	<input checked="" type="checkbox"/> <input checked="" type="checkbox"/>
OTHER DOCUMENTS					
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)			
EXAMINER <i>Rodney Fuller</i>				DATE CONSIDERED 10/26/2006	
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Examiner Initials	Cite No.	Document Number	Date	Name	
RF	9	5,969,441	10-19-1999	Loopstra et al.	
RF	10	6,246,204 B1	06-12-2001	Ebihara et al.	
RF	11	6,249,382 B1	06-19-2001	Komatsuda	
RF	12	6,262,796 B1	07-17-2001	Loopstra et al.	
RF	13	6,327,022 B1	12-4-2001	Nishi	
RF	14	6,337,162 B1	01-08-2002	Irie	
RF	15	6,341,007 B1	01-22-2002	Nishi et al.	
RF	16	6,677,088 B2	01-13-2004	Magome et al.	
FOREIGN PATENT DOCUMENTS					
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract With English Translation
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